



GAU-2621 #5

Attorney's Docket No. 74451.P110

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re Patent Application of:)
Kathrin Berkner) Examiner: Not yet assigned
Application No.: 09/658,393) Art Unit: 2621
Filed: September 8, 2000)
For: WAVELET-BASED IMAGE)
PROCESSING PATH)

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Assistant Commissioner for Patents
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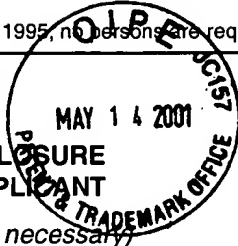
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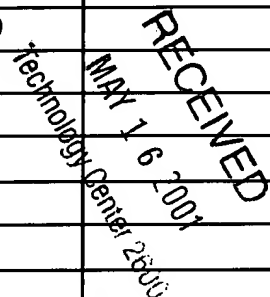
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Application Number	09/658,393
Filing Date	09/08/2000
First Named Inventor	Berkner
Group Art Unit	2621
Examiner Name	Not yet assigned
Attorney Docket Number	74451.P110

Sheet 1 of 9

U.S. PATENT DOCUMENTS

Examiner Initials *	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Filing Date if Appropriate
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OTHER DOCUMENTS

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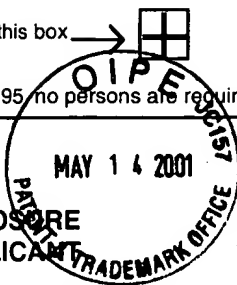
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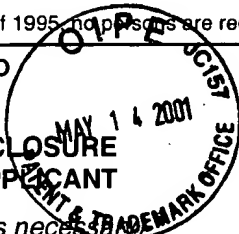
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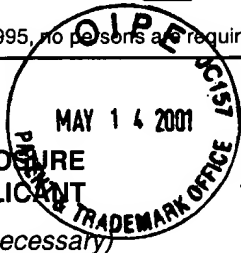
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